Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/807,338	CHO ET AL	
Examiner	Art Unit	
Ellen Kim	2874	

SEARCHED			
Class	Subclass	Date	Examiner
385	123,102	6/11/2007	EK
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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	Τ	Subclass Date		

	SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
		DATE	EXMR
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